

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/047,131	KAKU ET AL.	
Examiner	Art Unit	
Sam K. Ahn	2611	

SEARCHED						
Class	Subclass	Date	Examiner			
315	135,146 240.19 240.19 267,295	910     3/2e	an			
375	222,260,					
370	205					
714	700,701. 774,788	3/31	ar			
updated class/sub	search	8/7	an			
,						

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
375	all Subclasse above	8/7	an		
370	above				
714	t	8/7	ar		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EHST Inventor work keyword & nifetin semble 1888 & Gagle beyword stouch	3/28	a
CONSULTED WIFE  SPE Chich Fan (375)  P.E. Becure To, Faldet (375)  P.E. Andy Lee (370)	3/31	an
THT, IEEE & Google updated keyward & citation sarch	8/1	g